

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
37,275-00SERIAL NO.  
10/800,227LIST OF DOCUMENTS CITED BY APPLICANT  
(Use several sheets if necessary)APPLICANT  
Kleefisch, Mark S., et al.FILING DATE  
March 12, 2004

GROUP

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	<del>AA 4 2 9 4 0 2 3</del>					
	<del>AB 4 9 1 7 3 0 2</del>					
	<del>AC 5 0 8 2 2 9 3</del>					
	<del>AD 5 3 0 1 5 9 5</del>					
	<del>AE 5 3 5 6 7 2 8</del>					
	<del>AF 5 4 0 1 4 0 6</del>					
	<del>AG 5 8 2 0 6 5 3</del>					
	<del>AH 6 3 0 2 4 0 2</del>					
	<del>AI 6 4 5 4 2 7 4</del>					
	<del>AJ 6 5 4 7 2 8 0</del>					
	AK					

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>JK</i>	AL 0 3 9 9 8 3 3	11/28/90	EP			
	AM					
	AN					
	AO					
	AP					

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>JK</i>	AR	Battle et al., J. Solid State Chem. 76,334 (1988)
	AS	<del>Takeda, et al., Z. Anorg. Allg. Chem. 550/541, 259 (1986)</del>
	AT	<del>Teraoka, et al., Chem. Lett., 19, 1763 (1985)</del>

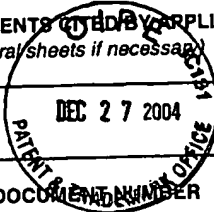

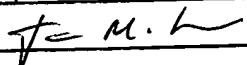
EXAMINER

*JE M.L.*

DATE CONSIDERED

6-7-06

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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						<b>GROUP</b>		
<div style="display: flex; justify-content: space-between; align-items: center;"> <div style="text-align: center;">  </div> <div> <b>U.S. PATENT DOCUMENTS</b> </div> </div>								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
							YES	NO
	AA							
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							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>								
	AR	Harder, et al., Z. Anorg. Allg. Chem. 464, 169 (1980)						
	AS	<del>Groaves, et al., Acta Cryst., B31, 641 (1975)</del>						
	AT	<del>Balachandran, et al., Proceedings International Gas Research Conf., Orlando, FL (H.A. Thompson, editor, Govt. Inst.), p. 565-573 (1992)</del>						
<b>EXAMINER</b> 				<b>DATE CONSIDERED</b> 6/7/06				
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